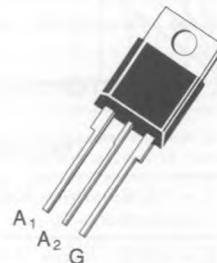


SNUBBERLESS TRIACS

- $I_{TRMS} = 6 \text{ A}$ at $T_c = 95^\circ\text{C}$.
- V_{DRM} : 200 V to 800 V.
- $I_{GT} = 50 \text{ mA}$ (QI-II-III).
- GLASS PASSIVATED CHIP.
- HIGH SURGE CURRENT : $I_{TSM} = 60 \text{ A}$.
- HIGH COMMUTATION CAPABILITY :
 $(di/dt)_c > 5 \text{ A/ms}$ without snubber.
- INSULATING VOLTAGE : 2500 V_{RMS}.


 TO 220 AB
 (CB-415 Plastic)

DESCRIPTION

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value		Unit
I_{TRMS}	RMS on-state current (360 ° conduction angle)	$T_c = 95^\circ\text{C}$	6	A
I_{TSM}	Non repetitive surge peak on-state current (T_j initial = 25 °C)	$t = 8.3 \text{ ms}$	63	A
		$t = 10 \text{ ms}$	60	
$I^2 t$	$I^2 t$ value	$t = 10 \text{ ms}$	18	$\text{A}^2 \text{s}$
di/dt	Critical rate of rise of on-state current (1)	Repetitive $F = 50 \text{ Hz}$	20	$\text{A}/\mu\text{s}$
		Non Repetitive	100	
T_{TJ}^{stg}	Storage and operating junction temperature range	- 40, + 150 - 40, + 125		°C °C

Symbol	Parameter	BTA 06-					Unit
		200 BW	400 BW	600 BW	700 BW	800 BW	
V_{DRM}	Repetitive peak off-state voltage (2)	± 200	± 400	± 600	± 700	± 800	V

 (1) Gate supply : $I_G = 500 \text{ mA}$ - $dI_G/dt = 1 \text{ A}/\mu\text{s}$.

 (2) $T_j = 125^\circ\text{C}$.

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R _{th (j - a)}	Junction to ambient	60	°C/W
R _{th (j - c)} DC	Junction to case for DC	4.3	°C/W
R _{th (j - c)} AC	Junction to case for 360° conduction angle (F = 50 Hz)	3.2	°C/W

GATE CHARACTERISTICS (maximum values)

P_{GM} = 40 W (t = 10 µs) P_{G(AV)} = 1 W I_{GM} = 4 A (t = 10 µs) V_{GM} = 16 V (t = 10 µs).

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions			Quadrants	Min.	Typ.	Max.	Unit
I _{GT}	T _j = 25 °C	V _D = 12 V	R _L = 33 Ω	I-II-III	2		50	mA
	Pulse duration > 20 µs							
V _{GT}	T _j = 25 °C	V _D = 12 V	R _L = 33 Ω	I-II-III			1.5	V
	Pulse duration > 20 µs							
V _{GD}	T _j = 125 °C	V _D = V _{DRM}	R _L = 3.3 kΩ	I-II-III	0.2			V
	Pulse duration > 20 µs							
I _H *	T _j = 25 °C	I _T = 100 mA					50	mA
	Gate open							
	R _L = 140 Ω							
I _G	T _j = 25 °C	V _D = 12 V	I _G = 500 mA	I-III		50		
	Pulse duration > 20 µs			II		100		mA
V _{TM} *	T _j = 25 °C	I _{TM} = 8.5 A	t _p = 10 ms				1.75	V
I _{DRM} *	T _j = 25 °C	V _{DRM} rated	Gate open				0.01	
	T _j = 125 °C						2	mA
dV/dt *	T _j = 125 °C	Gate open			500	750		V/µs
	Linear slope up to 0.67 V _{DRM}							
(di/dt) _c *	T _j = 125 °C	V _{DRM} rated			5	10		A/ms
	Without snubber							
t _{gt}	T _j = 25 °C	di _G /dt = 3.5 A/µs	I _G = 500 mA	I-II-III		2		µs
	I _T = 8.5 A	V _D = V _{DRM}						

* For either polarity of electrode A₂ voltage with reference to electrode A₁.

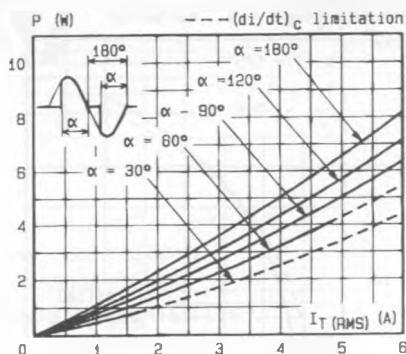


Fig.1 - Maximum mean power dissipation versus RMS on-state current ($F = 60$ Hz).

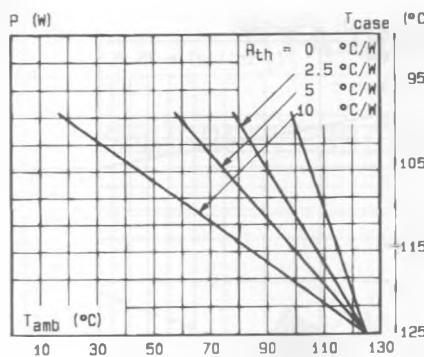


Fig.2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

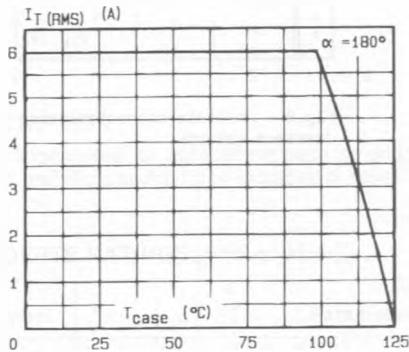


Fig.3 - RMS on-state current versus case temperature.

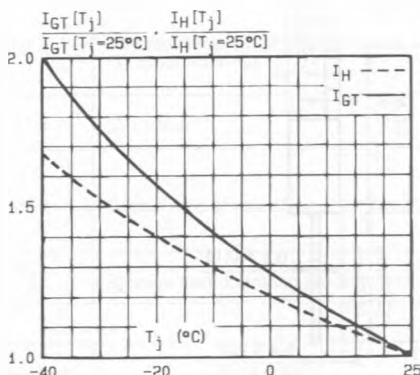


Fig.5 - Relative variation of gate trigger current and holding current versus junction temperature.

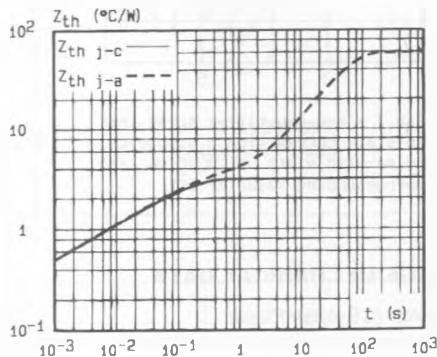


Fig.4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

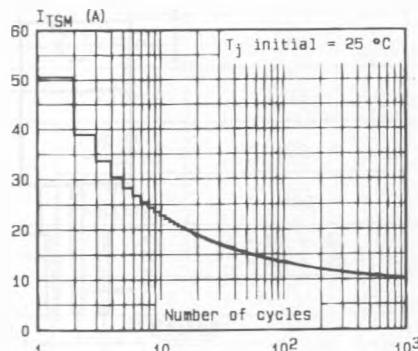


Fig.6 - Non repetitive surge peak on-state current versus number of cycles.

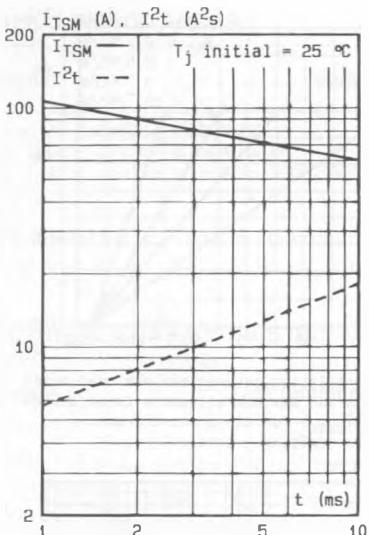


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \leq 10$ ms. and corresponding value of I^2t .

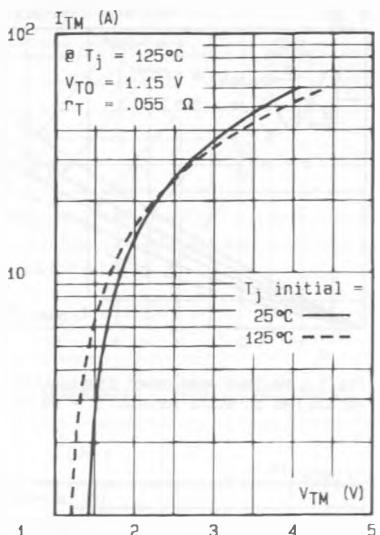
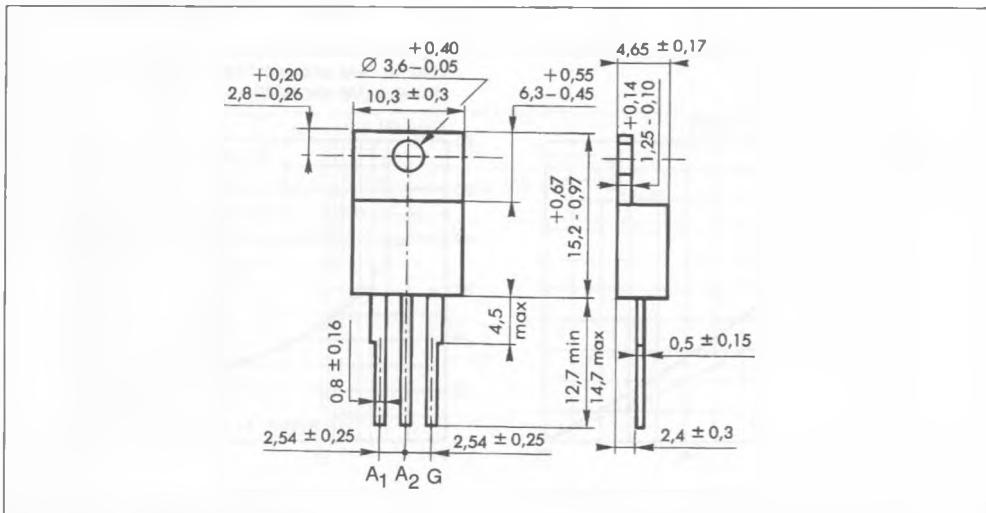


Fig.8 - On-state characteristics
(maximum values).

PACKAGE MECHANICAL DATA

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)

Marking : type number

Weight : 2 g